



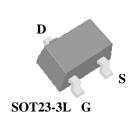
Description

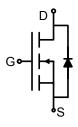
The XPX3400AS-D uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

- High power and current handing capability
- Lead free product is acquired
- Surface mount package
- PWM applications
- Load switch
- Power management

V DS =30V,ID =7.0A RDS(ON)=16mΩ (typ) @ VGS=-10V RDS(ON)=18mΩ (typ) @ VGS=4.5V





Schematic Diagram

Package Marking and Ordering Information

| Device Marking | Device | Device Package | Reel Size | Tape width | Quantity |
|----------------|-------------|----------------|-----------|------------|------------|
| XOHV2C | XPX3400AS-D | SOT-23-3L | Ø180mm | 8 mm | 3000 units |

Absolute Maximum Ratings (T_A=25 ℃unless otherwise noted)

| Parameter | Symbol | Limit | Unit |
|--|------------------|------------|------------|
| Drain-Source Voltage | V _{DS} | 30 | V |
| Gate-Source Voltage | V _G s | ±12 | V |
| Drain Current-Continuous | I _D | 7.0 | Α |
| Drain Current-Pulsed (Note 1) | I _{DM} | 22 | Α |
| Maximum Power Dissipation | P _D | 1.4 | W |
| Operating Junction and Storage Temperature Range | T_{J}, T_{STG} | -55 To 150 | $^{\circ}$ |
| Thermal Resistance,Junction-to-Ambient (Note 2) | R _{0JA} | 89 | °C/W |



Electrical Characteristics (T_A=25°C unless otherwise noted)

| Parameter | Symbol | Condition | Min | Тур | Max | Unit |
|------------------------------------|---------------------|--|-----|------|-----|------|
| Off Characteristics | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | V _{GS} =0V I _D =250μA | 30 | - | - | V |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} =30V,V _{GS} =0V | - | - | 1 | μA |
| Gate-Body Leakage Current | I _{GSS} | V _{GS} =±10V,V _{DS} =0V | - | - | ±10 | μA |
| On Characteristics (Note 3) | | | | | | |
| Gate Threshold Voltage | $V_{GS(th)}$ | $V_{DS}=V_{GS},I_{D}=250\mu A$ | 0.6 | 0.9 | 1.2 | V |
| | | V _{GS} =2.5V, I _D =4A | - | 23 | 35 | mΩ |
| Drain-Source On-State Resistance | R _{DS(ON)} | V _{GS} =4.5V, I _D =5A | - | 18 | 28 | mΩ |
| | | V _{GS} =10V, I _D =7.0A | - | 16 | 26 | mΩ |
| Forward Transconductance | g FS | V _{DS} =5V,I _D =5A | 10 | - | - | S |
| Dynamic Characteristics (Note4) | | | | | | |
| Input Capacitance | C _{Iss} | \/ 45\/\/ 0\/ | - | 597 | - | PF |
| Output Capacitance | Coss | V_{DS} =15V, V_{GS} =0V, F=1.0MHz | - | 66.4 | - | PF |
| Reverse Transfer Capacitance | C _{rss} | r-1.0ivinz | - | 58.8 | - | PF |
| Switching Characteristics (Note 4) | | | | | | |
| Turn-on Delay Time | t _{d(on)} | | - | 2.8 | - | nS |
| Turn-on Rise Time | t _r | V_{DD} =15V, R_L =2.8 Ω | - | 2.8 | - | nS |
| Turn-Off Delay Time | t _{d(off)} | V_{GS} =10 V , R_{GEN} =3 Ω | - | 25 | - | nS |
| Turn-Off Fall Time | t _f | | - | 4 | - | nS |
| Total Gate Charge | Qg | \/ -45\/ -7.04 | - | 9.8 | - | nC |
| Gate-Source Charge | Q _{gs} | V _{DS} =15V,I _D =7.0A | - | 2.6 | - | nC |
| Gate-Drain Charge | Q _{gd} | , V _{GS} =4.5V | - | 3.4 | - | nC |
| Drain-Source Diode Characteristics | | | | | | |
| Diode Forward Voltage (Note 3) | V _{SD} | V _{GS} =0V,I _S =7.0A | - | - | 1.2 | V |
| Diode Forward Current (Note 2) | Is | | - | | 7.0 | Α |

Notes:

- $\textbf{1.} \ \textbf{Repetitive Rating: Pulse width limited by maximum junction temperature.}$
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- **3.** Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production



Typical Electrical and Thermal Characteristics

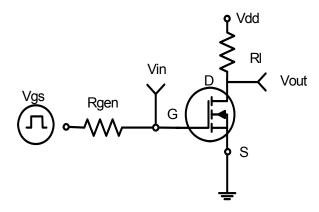


Figure 1:Switching Test Circuit

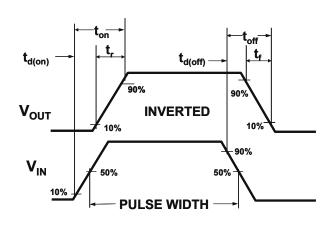


Figure 2:Switching Waveforms

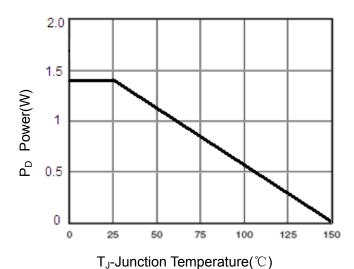


Figure 3 Power Dissipation

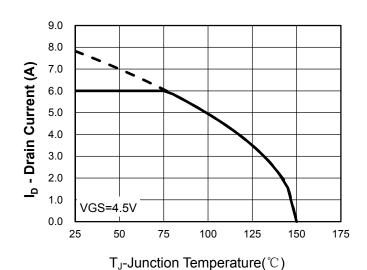


Figure 4 Drain Current

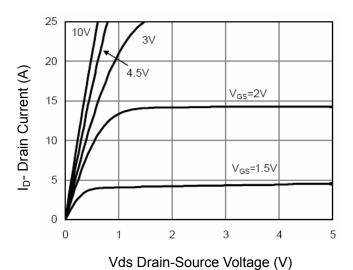


Figure 5 Output Characteristics

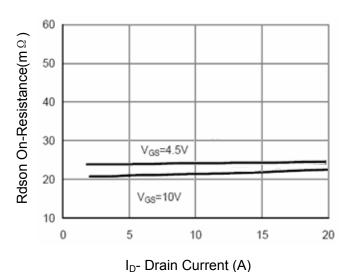


Figure 6 Drain-Source On-Resistance



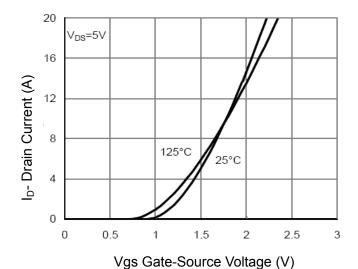
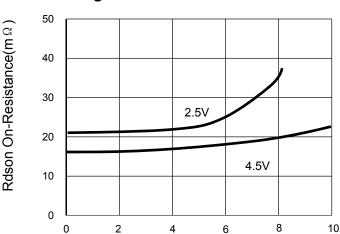
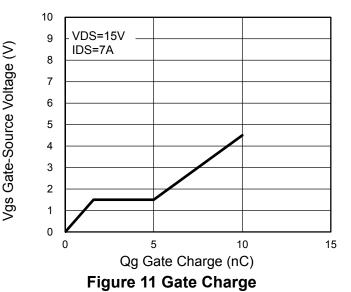


Figure 7 Transfer Characteristics

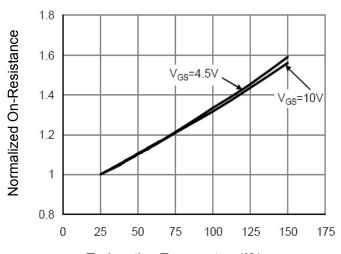


Vgs Gate-Source Voltage (V)

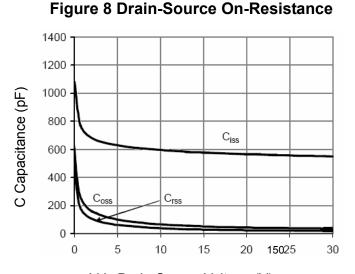
Figure 9 Rdson vs Vgs



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 $\mathsf{T}_{\mathsf{J}} ext{-Junction Temperature}(^{\mathbb{C}})$



Vds Drain-Source Voltage (V)

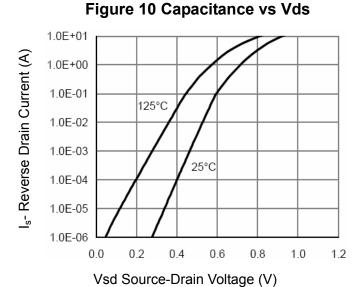
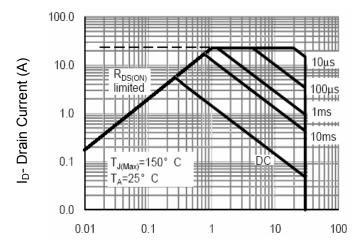


Figure 12 Source- Drain Diode Forward





Vds Drain-Source Voltage (V)

Figure 13 Safe Operation Area

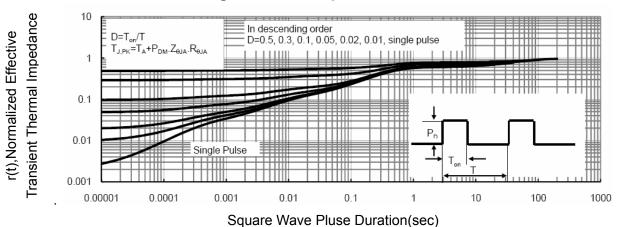
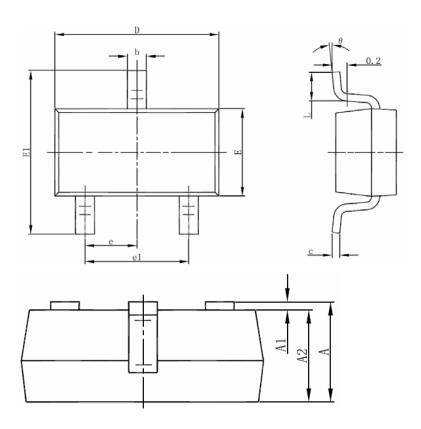


Figure 14 Normalized Maximum Transient Thermal Impedance



SOT-23-3L Package Information



| C. mla a l | Dimensions In Millimeters | | Dimensions In Inches | | |
|------------|---------------------------|-------|----------------------|-------|--|
| Symbol | Min | Max | Min | Max | |
| Α | 1.050 | 1.250 | 0.041 | 0.049 | |
| A1 | 0.000 | 0.100 | 0.000 | 0.004 | |
| A2 | 1.050 | 1.150 | 0.041 | 0.045 | |
| b | 0.300 | 0.500 | 0.012 | 0.020 | |
| С | 0.100 | 0.200 | 0.004 | 0.008 | |
| D | 2.820 | 3.020 | 0.111 | 0.119 | |
| E | 1.500 | 1.700 | 0.059 | 0.067 | |
| E1 | 2.650 | 2.950 | 0.104 | 0.116 | |
| е | 0.950(BSC) | | 0.037(BSC) | | |
| e1 | 1.800 | 2.000 | 0.071 | 0.079 | |
| L | 0.300 | 0.600 | 0.012 | 0.024 | |
| θ | 0° | 8° | 0° | 8° | |

Notes

- 1. All dimensions are in millimeters.
- 2. Tolerance ±0.10mm (4 mil) unless otherwise specified
- 3. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 5 mils.
- 4. Dimension L is measured in gauge plane.
- 5. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.



Flow (wave) soldering (solder dipping)

| Product | Peak Temperature | Dipping Time |
|----------------|--------------------------|--------------|
| Pb device | 245 ℃ ±5 ℃ | 5sec±1sec |
| Pb-Free device | 260℃+0/-5℃ | 5sec±1sec |



This integrated circuit can be damaged by ESD UniverChip Corporation recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedure can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

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